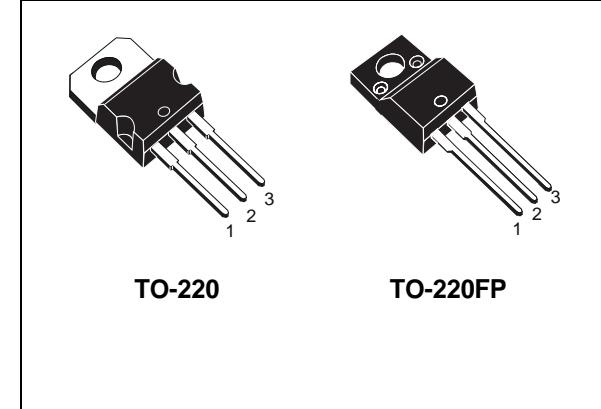


STP16NS25 STP16NS25FP

**N-CHANNEL 250V - 0.23Ω - 16A TO-220 / TO-220FP
MESH OVERLAY™ MOSFET**

TYPE	V _{DSS}	R _{D(on)}	I _D
STP16NS25	250 V	< 0.28 Ω	16 A
STP16NS25FP	250 V	< 0.28 Ω	16 A

- TYPICAL R_{D(on)} = 0.23 Ω
- EXTREMELY HIGH dv/dt CAPABILITY
- 100% AVALANCHE TESTED



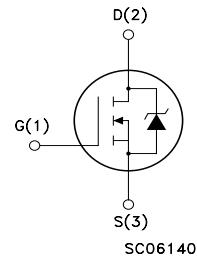
DESCRIPTION

Using the latest high voltage MESH OVERLAY™ process, STMicroelectronics has designed an advanced family of power MOSFETs with outstanding performance. The new patented STrip layout coupled with the Company's proprietary edge termination structure, makes it suitable in converters for lighting applications.

APPLICATIONS

- HIGH CURRENT, HIGH SPEED SWITCHING
- SWITH MODE POWER SUPPLIES (SMPS)
- DC-DC CONVERTERS FOR TELECOM,
INDUSTRIAL, AND LIGHTING EQUIPMENT
- IDEAL FOR MONITOR's B+ FUNCTION

INTERNAL SCHEMATIC DIAGRAM



ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value		Unit
		STP16NS25	STP16NS25FP	
V _{DS}	Drain-source Voltage (V _{GS} = 0)	250		V
V _{DGR}	Drain-gate Voltage (R _{GS} = 20 kΩ)	250		V
V _{GS}	Gate- source Voltage	± 20		V
I _D	Drain Current (continuos) at T _C = 25°C	16	16(*)	A
I _D	Drain Current (continuos) at T _C = 100°C	11	11(*)	A
I _{DM} (*)	Drain Current (pulsed)	64	64(*)	A
P _{TOT}	Total Dissipation at T _C = 25°C	140	40	W
	Derating Factor	1	0.33	W/°C
dv/dt (1)	Peak Diode Recovery voltage slope	5		V/ns
V _{ISO}	Insulation Withstand Voltage (DC)	-	2500	V
T _{stg}	Storage Temperature	-65 to 150		°C
T _j	Max. Operating Junction Temperature			

(*)Pulse width limited by safe operating area

(1) I_D≤ 16A, di/dt≤300 A/μs, V_{DD}≤ V_{(BR)DSS}, T_j≤T_{jMAX}

STP16NS25 - STP16NS25FP

THERMAL DATA

		TO-220	TO-220FP	°C/W
R _{thj-case}	Thermal Resistance Junction-case Max	0.9	3	°C/W
R _{thj-amb} T _I	Thermal Resistance Junction-ambient Max Maximum Lead Temperature For Soldering Purpose	62.5 300		°C/W °C

AVALANCHE CHARACTERISTICS

Symbol	Parameter	Max Value	Unit
I _{AR}	Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by T _j max)	16	A
E _{AS}	Single Pulse Avalanche Energy (starting T _j = 25 °C, I _D = I _{AR} , V _{DD} = 50 V)	600	mJ

ELECTRICAL CHARACTERISTICS (TCASE = 25 °C UNLESS OTHERWISE SPECIFIED) OFF

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V _{(BR)DSS}	Drain-source Breakdown Voltage	I _D = 250 μA, V _{GS} = 0	250			V
I _{DSS}	Zero Gate Voltage Drain Current (V _{GS} = 0)	V _{DS} = Max Rating V _{DS} = Max Rating, T _C = 125 °C			1 10	μA μA
I _{GSS}	Gate-body Leakage Current (V _{DS} = 0)	V _{GS} = ± 20 V			±100	nA

ON (1)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250 μA	2	3	4	V
R _{D(on)}	Static Drain-source On Resistance	V _{GS} = 10V, I _D = 8 A		0.23	0.28	Ω

DYNAMIC

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
g _{fs} (1)	Forward Transconductance	V _{DS} > I _{D(on)} × R _{D(on)max} , I _D = 8 A		15		S
C _{iss}	Input Capacitance	V _{DS} = 25V, f = 1 MHz, V _{GS} = 0		1270		pF
C _{oss}	Output Capacitance			190		pF
C _{rss}	Reverse Transfer Capacitance			74		pF

ELECTRICAL CHARACTERISTICS (CONTINUED)

SWITCHING ON

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on Delay Time	$V_{DD} = 125\text{ V}$, $I_D = 8\text{ A}$ $R_G = 4.7\Omega$, $V_{GS} = 10\text{ V}$ (see test circuit, Figure 3)		14.5		ns
t_r	Rise Time			26		ns
Q_g	Total Gate Charge	$V_{DD} = 200\text{V}$, $I_D = 16\text{ A}$,		59		nC
Q_{gs}	Gate-Source Charge	$V_{GS} = 10\text{V}$		7.9		nC
Q_{gd}	Gate-Drain Charge			22.3		nC

SWITCHING OFF

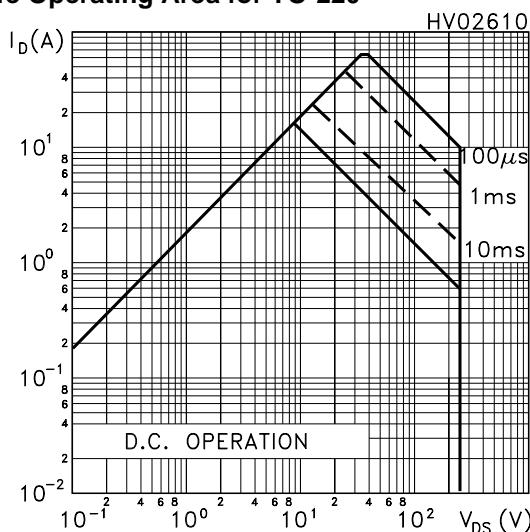
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$t_{d(Voff)}$ t_f	Turn-off- Delay Time Fall Time	$V_{DD} = 125\text{V}$, $I_D = 8\text{ A}$, $R_G = 4.7\Omega$, $V_{GS} = 10\text{V}$ (see test circuit, Figure 3)		72 32		ns ns
$t_{r(Voff)}$ t_f t_c	Off-voltage Rise Time Fall Time Cross-over Time	$V_{clamp} = 200\text{V}$, $I_D = 16\text{ A}$, $R_G = 4.7\Omega$, $V_{GS} = 10\text{V}$ (see test circuit, Figure 5)		24 28 56		ns ns ns

SOURCE DRAIN DIODE

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
I_{SD}	Source-drain Current				16	A
$I_{SDM}(2)$	Source-drain Current (pulsed)				64	A
$V_{SD}(1)$	Forward On Voltage	$I_{SD} = 16\text{ A}$, $V_{GS} = 0$			1.5	V
t_{rr}	Reverse Recovery Time	$I_{SD} = 16\text{ A}$, $dI/dt = 100\text{A}/\mu\text{s}$		270		ns
Q_{rr}	Reverse Recovery Charge	$V_{DD} = 30\text{V}$, $T_j = 150^\circ\text{C}$		1.5		μC
I_{RRM}	Reverse Recovery Current	(see test circuit, Figure 5)		11.4		A

Note: 1. Pulsed: Pulse duration = 300 μs , duty cycle 1.5 %.
2. Pulse width limited by safe operating area.

Safe Operating Area for TO-220



Safe Operating Area for TO-220FP

